



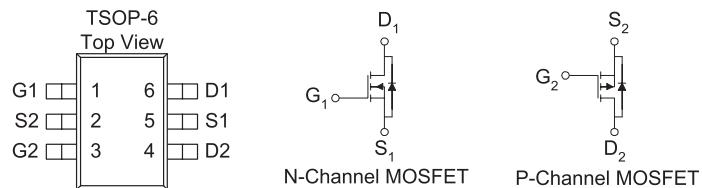
N & P-Channel 30-V (D-S) MOSFET

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $r_{DS(on)}$ and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

- Low $r_{DS(on)}$ provides higher efficiency and extends battery life
- Low thermal impedance copper leadframe TSOP-6 saves board space
- Fast switching speed
- High performance trench technology

PRODUCT SUMMARY

V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
30	0.058 @ $V_{GS} = 4.5V$	3.7
	0.082 @ $V_{GS} = 2.5V$	3.1
-26.5	0.112 @ $V_{GS} = -4.5V$	-2.7
	0.172 @ $V_{GS} = -2.5V$	-2.2



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	N-Channel	P-Channel	Units
Drain-Source Voltage	V_{DS}	30	-26.5	V
Gate-Source Voltage	V_{GS}	± 12	± 12	
Continuous Drain Current ^a	I_D	3.7	-2.7	A
		2.9	-2.1	
Pulsed Drain Current ^b	I_{DM}	8	-8	
Continuous Source Current (Diode Conduction) ^a	I_S	1.05	-1.05	A
Power Dissipation ^a	P_D	1.15		W
		0.7		
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150		°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	N-Channel		P-Channel		Unit
		Typ	Max	Typ	Max	
Maximum Junction-to-Ambient ^a	R_{thJA}	93	110	93	110	°C/W
		130	150	130	150	

Notes

- Surface Mounted on 1" x 1" FR4 Board.
- Pulse width limited by maximum junction temperature

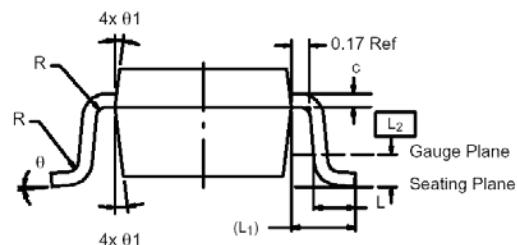
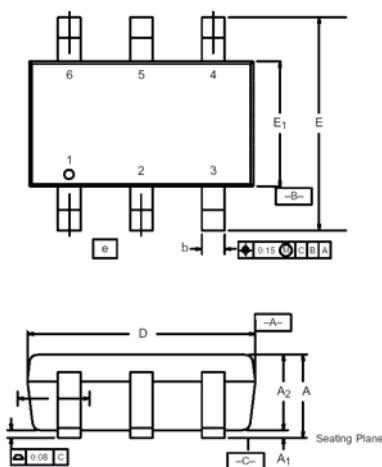
SPECIFICATIONS ($T_A = 25^\circ C$ UNLESS OTHERWISE NOTED)							
Parameter	Symbol	Test Conditions	Limits				Unit
			Ch	Min	Typ	Max	
Static							
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_D = 250 \mu A$	N	0.6			V
		$V_{GS} = V_{DS}, I_D = -250 \mu A$	P	-0.6			
Gate-Body Leakage Current	I_{GSS}	$V_{DS} = 0 V, V_{GS} = 12 V$	N			100	μA
		$V_{DS} = 0 V, V_{GS} = -12 V$	P			-100	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 21 V, V_{GS} = 0 V$	N			1	μA
		$V_{DS} = -21 V, V_{GS} = 0 V$	P			-1	
		$V_{DS} = 21 V, V_{GS} = 0 V, T_J = 55^\circ C$	N			10	μA
		$V_{DS} = -24 V, V_{GS} = 0 V, T_J = 55^\circ C$	P			-10	
On-State Drain Current ^A	$I_{D(on)}$	$V_{DS} = 5 V, V_{GS} = 4.5 V$	N	5			A
		$V_{DS} = -5 V, V_{GS} = -4.5 V$	P	-5			
Drain-Source On-Resistance ^A	$r_{DS(on)}$	$V_{GS} = 4.5 V, I_D = 3.7 A$	N			0.058	Ω
		$V_{GS} = -4.5 V, I_D = 3.1 A$	P			0.112	
		$V_{GS} = 2.5 V, I_D = 2.7 A$	N			0.08	
		$V_{GS} = -2.5 V, I_D = -2.2 A$	P			0.17	
Forward Tranconductance ^A	g_{fs}	$V_{DS} = 5 V, I_D = 3.7 A$	N		10		S
		$V_{DS} = -5 V, I_D = 3.1 A$	P		5		
Diode Forward Voltage ^A	V_{SD}	$I_S = 1.05 A, V_{GS} = 0 V$	N		0.80		S
		$I_S = -1.05 A, V_{GS} = 0 V$	P		-0.83		
Dynamic ^b							
Total Gate Charge	Q_g	N-Channel $V_{DS}=15V, V_{GS}=4.5V, I_D=2.7A$ P-Channel $V_{DS}=-15V, V_{GS}=-4.5V, I_D=-3.1A$	N		6.3		nC
Gate-Source Charge	Q_{gs}		P		3.8		
Gate-Drain Charge	Q_{gd}		N		0.9		
Turn-On Delay Time	$t_{d(on)}$		P		0.6		
Rise Time	t_r		N		1.9		
Turn-Off Delay Time	$t_{d(off)}$		P		1.5		
Fall Time	t_f	N-Chanel $V_{DD}=15V, V_{GS}=4.5V, I_D=1A$, $R_{GEN}=15\Omega$, P-Channel $V_{DD}=-15V, V_{GS}=-4.5V, I_D=-1A$, $R_{GEN}=15\Omega$	N		5		nS
Notes			P		5		
			N		12		
			P		15		
			N		13		
			P		20		
			N		7		
			P		20		

a. Pulse test: PW <= 300us duty cycle <= 2%.

b. Guaranteed by design, not subject to production testing.

Package Information

TSOP-6: 6LEAD



Dim	MILLIMETERS			INCHES		
	Min	Nom	Max	Min	Nom	Max
A	0.91	—	1.10	0.036	—	0.043
A₁	0.01	—	0.10	0.0004	—	0.004
A₂	0.84	—	1.00	0.033	0.038	0.039
b	0.30	0.32	0.45	0.012	0.013	0.018
c	0.10	0.15	0.20	0.004	0.006	0.008
D	2.95	3.05	3.10	0.116	0.120	0.122
E	2.70	2.85	2.98	0.106	0.112	0.117
E₁	1.55	1.65	1.70	0.061	0.065	0.067
e	1.00 BSC			0.0394 BSC		
L	0.35	—	0.50	0.014	—	0.020
L₁	0.60 Ref			0.024 Ref		
L₂	0.25 BSC			0.010 BSC		
R	0.10	—	—	0.004	—	—
θ	0°	4°	8°	0°	4°	8°
θ₁	7° Nom			7° Nom		